

## ELECTRICAL CHARACTERISTICS

The electrical characteristics of a SMT50 device are similar to that of a self-gated Triac, but the SMT50 is a two terminal device with no gate. The gate function is achieved by an internal current controlled mechanism.

Like the T.V.S. diodes, the SMT50 has a standoff voltage ( $V_{rm}$ ) which should be equal to or greater than the operating voltage of the system to be protected. At this voltage ( $V_{rm}$ ) the current consumption of the SMT50 is negligible and will not affect the protected system.

When a transient occurs, the voltage across the SMT50 will increase until the breakdown voltage ( $V_{br}$ ) is reached. At this point the device will operate in a similar way to a T.V.S. device and is in avalanche mode.

The voltage of the transient will now be limited and will only increase by a few volts as the device diverts more current. As this transient current rises, a level of current through the

device is reached ( $I_{bo}$ ) which causes the device to switch to a fully conductive state such that the voltage across the device is now only a few volts ( $V_t$ ). The voltage at which the device switched from the avalanche mode to the fully conductive state ( $V_t$ ) is known as the Breakover voltage ( $V_{bo}$ ). When the device is in the  $V_t$  state, high currents can be diverted without damage to the SMT50 due to the low voltage across the device, since the limiting factor in such devices is dissipated power ( $V \times I$ ).

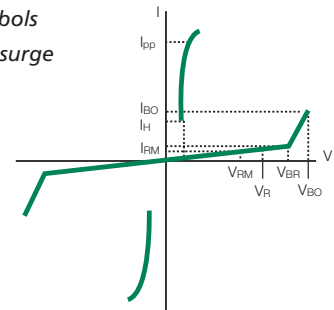
Resetting of the device to the non-conducting state is controlled by the current flowing through the device. When the current falls below a certain value, known as the Holding Current ( $I_h$ ), the device resets automatically.

As with the avalanche T.V.S. device, if the SMT50 is subjected to a surge current which is beyond its maximum rating, then the device will fail in short circuit mode, ensuring that the equipment is ultimately protected.

## SELECTING A SMT50

1. When selecting a SMT50 device, it is important that the  $V_{rm}$  of the device is equal to or greater than the the operating voltage of the system.
2. The minimum Holding Current ( $I_h$ ) must be greater than the current the system is capable of delivering otherwise the device will remain conducting following a transient condition.

*V-I Graph illustrating symbols and terms for the SMT50 surge protection device.*



COMPLIES WITH THE FOLLOWING STANDARDS	PEAK SURGE VOLTAGE (V)	VOLTAGE WAVEFORM ( $\mu$ S)	CURRENT WAVEFORM ( $\mu$ S)	ADMISSIBLE IPP (A)	NECESSARY RESISTOR ( $\Omega$ )
(CCITT) ITU-K20	1000	10/700	5/310	25	-
(CCITT) ITU-K17	1500	10/700	5/310	38	-
VDE0433	2000	10/700	5/310	50	-
VDE0878	2000	1.2/50	1/20	50	-
IEC-1000-4-5	level 3	10/700	5/310	50	-
	level 4	1.2/500	8/20	100	-
FCC Part 68, lightning surge type A	1500	10/160	10/160	75	12.5
	800	10/560	10/560	55	6.5
FCC Part 68, lightning surge type B	1000	9/720	5/320	25	-
Bellcore TR-NWT-001089 first level	2500	2/10	2/10	150	11.5
	1000	10/1000	10/1000	50	10
Bellcore TR-NWT-001089 second level	5000	2/10	2/10	150	11.5
CNET I31-24	1000	0.5/700	0.8/310	25	-

**ELECTRICAL CHARACTERISTICS (Tamb 25°C)**

SYMBOL	PARAMETER	SYMBOL	PARAMETER
$V_{RM}$	Stand-off Voltage	$V_{BO}$	Breakover Voltage
$I_{RM}$	Leakage Current at Stand-off Voltage	$I_H$	Holding Current
$V_R$	Continuous Reverse Voltage	$I_{BO}$	Breakover Current
$V_{BR}$	Breakdown Voltage	$I_{PP}$	Peak pulse Current
C	Capacitance		

**THERMAL RESISTANCE**

SYMBOL	PARAMETER	VALUE	UNIT
$R_{TH} (J-I)$	Junction to leads	20	°C/W
$R_{TH} (J-l)$	Junction to ambient on printed circuit (with standard footprint dimensions)	100	°C/W

**ABSOLUTE MAXIMUM RATINGS (Tamb 25°C)**

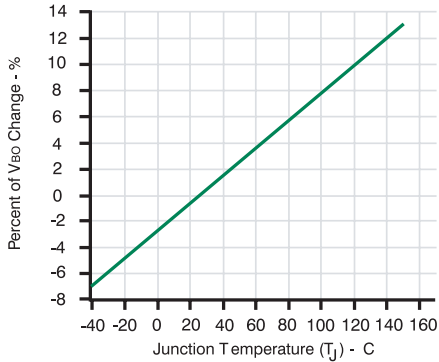
SYMBOL	PARAMETER		VALUE	UNIT
P	Power dissipation	$T_{lead}$	5	W
$I_{PP}$	Peak pulse current	10/1000 $\mu$ S	50	A
		8/20 $\mu$ S	100	A
$I_{TSM}$	Non repetitive surge peak on-state current	tp + 20ms	30	A
dV/dt	Critical rate of rise of off-state voltage	$V_{RM}$	5	KV/ $\mu$ S
$T_{stg}$	Storage temperature range		-55 to +150	°C
$T_j$	Maximum junction temperature		150	°C
$T_L$	Maximum lead temperature for soldering during 10s		260	$T_{stg}$

Type	Marking	$I_{RM} @ V_{RM}$ MAX		$I_{RM} @ V_R$ MAX		$V_{BO} @ I_{BO}$ MAX		$I_H$ MIN (Note 1) (mA)	C MAX (pF)
		( $\mu$ A)	(V)	( $\mu$ A)	(V)	(V)	(mA)		
SMT50-62	A062	2	56	50	62	82	800	150	150
SMT50-68	A068	2	60	50	68	90	800	150	150
SMT50-100	A100	2	90	50	100	133	800	150	100
SMT50-120	A120	2	180	50	120	160	800	150	100
SMT50-130	A130	2	117	50	130	173	800	150	100
SMT50-180	A180	2	162	50	180	240	800	150	100
SMT50-200	A200	2	180	50	200	267	800	150	100
SMT50-220	A220	2	198	50	220	293	800	150	100
SMT50-240	A240	2	216	50	240	320	800	150	100
SMT50-270	A270	2	243	50	270	360	800	150	100

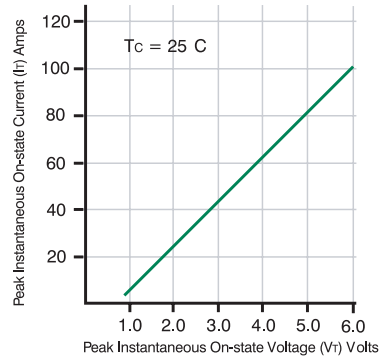
All parameters are tested @ 25°C except where indicated.

Note 1: Measured @ 1V bias, 1MHz All parameters are tested using a FET TEST™ model 3600

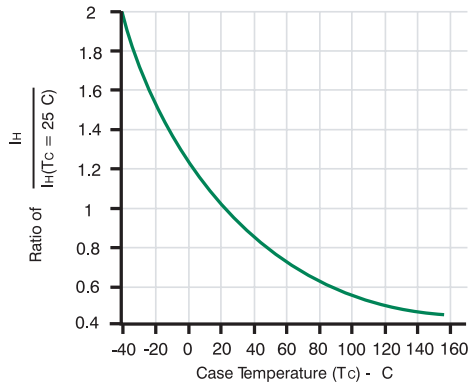
TYPICAL VBO CHANGE vs JUNCTION TEMPERATURE



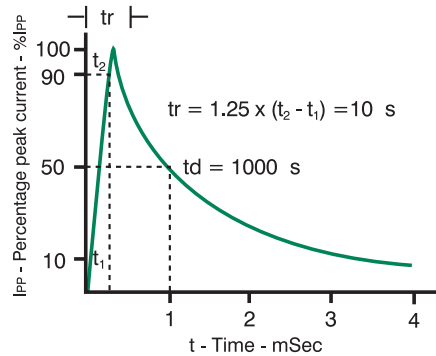
ON-STATE VOLTAGE (VT) vs ON-STATE CURRENT (IT)



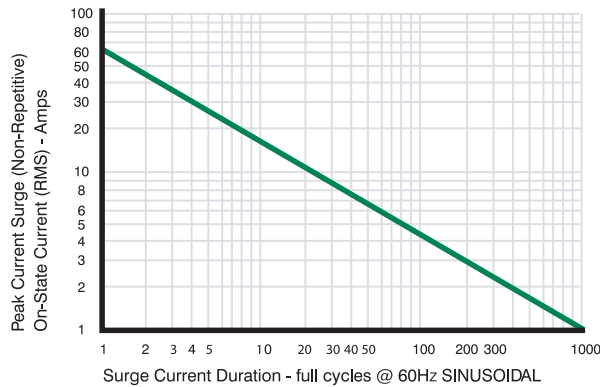
TYPICAL DC HOLDING CURRENT vs CASE TEMPERATURE



PULSE WAVE FORM (10/1000μS)

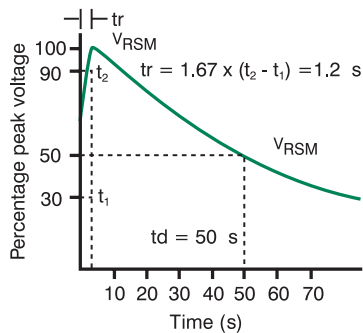


PEAK SURGE ON-STATE CURRENT vs SURGE CURRENT DURATION



INTERNATIONAL EMISSIONS STANDARD IEC 1000-4-5

1.2/50μS IMPULSE DISCHARGE VOLTAGE WAVESHAVE



8/20μS IMPULSE DISCHARGE CURRENT WAVESHAVE

